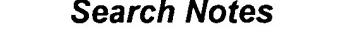


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/036,120	MATSUMOTO ET AL.
	Examiner Calvin L. Hewitt II	Art Unit 3621

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner